



PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl'n of:

Kenneth R. Crounse

Art Unit: 2624

Appl'n no.:

10/007,440

Examiner: Thompson, James A.

Filed:

December 4, 2001

For:

HALFTONING WITH UNIFORMLY DISPERSED DOT GROWTH

DECLARATION UNDER 37 C.F.R. §1.131

Commissioner for Patents P.O. Box 1450 Alexandria, VA. 22313-1450

Dear Sir or Madam:

- I, Kenneth R. Crounse, do declare and state:
- 1. I am the sole inventor of claims 1-44 of the above-identified patent application.
- 2. I am the author of the attached *draft* 3 page Patent Application: Automatic Generation of Dither Patterns With Uniform Dispersion, Draft 1.0 dated 6/29/01, and the accompanying 3 pages of hand-written notes.
- 3. Prior to August 27, 2001, I completed the invention as described and claimed in the aboveidentified patent application as evidenced by:
- A. The attached 3 pages of my hand-written notes dated 22 June, 7/11 and 7/13 all in the year 2000 as further evidenced by my insertion on the attached "Agfa Corporation Memorandum of Invention" form. The date of 7/11/00 of the Orig. Notebook Disclosure was hand written by me onto the "Agfa Corporation Memorandum of Invention" form.
- B. The "Agfa Corporation Memorandum of Invention" form was signed by me on June 29, 2001.
- C. The *draft* 3 page Patent Application: Automatic Generation of Dither Patterns With Uniform Dispersion, Draft 1.0 dated 6/29/01 was authored by me.
- D. I reduced to practice my invention by successfully testing proper operation on a computer system prior to 8/27/01 as evidenced by the attached software code document dated 2/13/01, which includes code that has been blackened out to prevent copying.

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DECLARATION UNDER 37 C.F.R. §1.131 (cont)

I declare that all statements made herein of my own knowledge are true and that all statements made on information and belief are believed to be true, and further that these statements were made with the knowledge that willful false statements and the like so made are punishable by fine or imprisonment, or both, under §1001 of Title 18 of the United States Code and that such willful false statements may jeopardize the validity of the application or any patent issuing thereon.

Kennet M. Com	4/24/2006
Kenneth R. Crounse	Date

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AGFA CORPORATION MEMORANDUM OF INVENTION

Patent Department MS 200-4-LEGAL

Full Name of Each Inventor	Home Address/Citizenship/	Phone Ext.	
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	Title of Invention:		
Description of Invention:		2: W. G.	Na Cas ith
A method for choosing the dither pattern for clustered	Automatic Generation of Unitorn Disposion	D there	THE IS WIT
dot screening.	Officers, Distriction		
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(Check all that apply):		.	
Invention: Documentation:	Date(s) if known	Refere	nce
Invented in US Orig Notebook Disclosure	7/11/00		
US Inventors Orig. Drawings / Sketches			
Non-US Inventors Software Listings			
Non-Agfa Inventors Foreign Priority Application			·
Joint Agreement Built and Tested in US			
First Disclosed to: Dale Hubbard			
First Commercial Use:			
Now in use Internally; output sent to lexing Product Name:	nork, Minolth QMS.	sed since:	Dec 2000
Planned future use Product Name or type: (Lexnax Tib) 7/01)	V	FCS date:	8 101
Please attach originals or Photostat copies of any materials checked block diagram and a brief description of the invention, including: (1 Principle of working, operation, or construction of the invention. No) Field to which invention relate	s; (2) Purpo	r with a drawing or use of the invention; (3)
Signature of Inventor(s):			
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Witnessed by: Witnessed by: This	29-JUN day o	f_ JU	WE -700/2000
(Witness should, if possible, be those to whom the invention was disclosed)	The Market State of the State o	effort 1 10 20 12機能と	
(For Patent Department Use)			
XP Case Number: XP-1002-TitkerPa	Hen Opened Date:	üly /	b,0/

Patent Application: Automatic Generation of Dither Patterns with Uniform Dispersion

Kenneth R. Crounse Agfa Monotype Corp.

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Background

A common approach to creating digital halftones is by using a threshold mask to simulate the classical optical approach. This mask is an array of thresholds that spatially correspond to the addressable points on the output medium. At each location an input value is compared to a threshold to make the decision whether to print a dot or not. A small mask (tile) can be used on a large image by applying it periodically.

The first threshold masks were designed to emulate the classical screens. In the simplest case these screens produce halftone dots that are arranged along parallel lines in two directions, i.e. at the vertices of a parallelogram tiling of the plane. If the two directions are orthogonal, the screen can be specified by a single angle and frequency. The halftone dots grow according to a spot function as the desired coverage increases. Many methods have been developed for converting an angle, frequency, and spot function specification to a digital representation, all representing various trade-offs among memory requirements, implementation complexity, and aliasing effects due to the quantization of space

Agfa Balanced Screening allows the use of a square tile to produce screens closely approximating any angle or reasonable frequency. The ABS parameters determine the number of halftone dots contained within a tile and their locations. The dot centers do not necessarily lie on the underlying printer grid, but may be "virtual". When the threshold mask is being computed, the halftone dots are created out of real device dot locations which grow around these virtual centers. Furthermore, to allow for more possible levels of coverage, the dot growth is dithered. This means that the halftone dots do not grow synchronously; instead each is grown independently in a pre-determined order. Determining this order is the subject of this invention.

The Problem

The order in which dots grow has a significant effect of apparent screen quality. If the new dots are added in a manner that is not well dispersed, the output may appear mottled or grainy. These problems may be especially visible in devices that have very visible device dots or for which there are sudden jumps in the tone reproduction curve. Furthermore, in such devices the interaction between dot growth order in different channels may be important. For example, if the cyan and magenta dot growth locations



are significantly similar, the dither pattern will be more visible than if they were more dispersed

The Bayer dither is a recursively-defined pattern which is known to have optimal dispersion properties. Among other things, the Bayer dither pattern is independent of scale – dots will be placed based only on their relative positions to the other dots. The Bayer dither is most easily applied to a square periodic array of an even power of two number of elements. For these reasons, it cannot be directly applied to the ABS dot center grid (except in the 0 degree case) because the dot centers are oriented at a different angle than the tile shape, and any number of dots are possible. Even in cases where the Bayer dither could be used it is not necessarily desirable in printing systems with visible dots due to the highly regular patterns produced.

Other methods have also been developed for dithering among a small number of dot centers. These methods typically employ a function or set of functions as a measure of dispersion. These functions are evaluated at each potential site for the next dither location, as a function of previously chosen nearby dither locations, and the optimal site is chosen. These functions are usually embody two strategies: maximizing the distance from adjacent dots in the pattern and minimizing the variance among those distances. Such strategies are best used with a small number of dot centers because they are inherently local—if many potential sites were to have similar neighborhoods the method could only choose among them at random. This can lead to unpleasant white-noise structure at various levels in the dither pattern.

Summary of the Invention

Our invention creates a dither pattern for a large number of dot centers with the both global and local (scale-invariant) properties of the Bayer dither, but with the less-obvious structures that can be produced by other methods. The method is based on the minimization of a convolution-style "cost" functional $H_j = \sum_k f(d_{jk})$. That is, each

potential next dot center in the dither order is evaluated in terms of a sum of a specific function f of the distances between the candidate dot center and all other previously chosen dot centers. The dot with the minimum "cost" is chosen, and the process is iterated.

There are an infinite number of possible functions of distance that could be considered, but the properties of this function are critical. For example, it seems reasonable to find a dot center that is furthest away from all others by minimizing the negative sum of square distances. However, attempting to apply this cost function can lead to the situation where dots are placed very close to each other in two separate clumps. In fact, it can be shown that the cost function must be sufficiently concave as a function of distance (the sum of distances is not), which ensures that local decisions take priority over global ones. Another feature the function should contain is invariance to arbitrary dilations or contractions of scale. That is, if the units of measurement are arbitrarily scaled, the costs



Confidential Draft 1.0 6/29/2001

will maintain their relationships. This straightforward requirement is essential for scale-invariance but is not found in such promising functions as the gaussian or exponential decay functions

The class of functions that we have chosen for this purpose is the power laws:

$$f \equiv \frac{1}{d^{\alpha}}$$
 where $\alpha > 1$,

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which can be shown to have the desired properties. In fact, when using this function and starting with any single initial dot center, the algorithm will produce an ideal Bayer dither pattern (up to certain symmetries) on any tile where it is possible. In other cases, the Bayer pattern is produced up to the point where the sub-grids contain no further factors of two. To produce patterns with less structure the algorithm must be initialized with two or more chosen dot centers which are not symmetric. Then, the pattern produced will still maintain both local and global dispersion but will not follow the standard Bayer dither order.

When designing dot dither order for two screens simultaneously, a similar technique can be used. The next dot in the order is chosen for each screen alternately. First the cost function described above is used to assess the possible locations. Then, a (possibly different) measure of the dispersion to the chosen centers in the other screen is also evaluated. These two results are combined to produce a best choice. There are many possible choices of the cross-screen dispersion measure and the method of combining the two cost functions. The cross-screen dispersion measure does not need to have global properties, since this is preferably handled by the self-dispersion measure. For this reason we use the negative maximal minimum distance as the cross-screen dispersion measure. These measures are combined by first selecting the N best choices according to the self-dispersion measure, and then selecting of those the one with the best cross-screen dispersion. As the number of selected dots increases and the choices become more constrained, N can be decreased so that self-dispersion is given more priority

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162 of way	
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with from 6/22 Dut Dither Order Observations - since the pattern is periodic any "energy" function is also periodic, need only consider one period centered at the coll under consideration * This is equivalent to Paul's method of finding the "closest" periodic replication of a given dot. Sink only on period is considered i maximizing a functional canbe recort as a minimization $\max \sum f(r_k) \equiv \min \sum -f(r_k) + C$ where C= max f(r) but numerically one or the ther may be preferable when naximizing, a concave Poinchon like 12 is not apparentel since it favois endpoints, not midpoints now any for adjust both fuil on some important (uses, in particular o trying 12 which does seem to work on the case of interest of for all scales + ideally would dike an analytical decision -> seems to work very will, producing - Buyer potterur. Would be new 10 - did this by fixing a dot at nd/3 I jime kette "king range decisions ...

	
27/13	Dut Order Pither
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	as perde as 1000 (person person)
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	Directions to take Order file generation.
	1) speed. The algorithm is very inefficiently implemented.
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	<u> </u>
	2) breaking symmetry right now I'm choosing cell 0 and cell nd/3 to start
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1)	which give somes symmetry breaking. For small tile sizes, it leads to Some bothersome phase boundaries.
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	4) adjustable anisotropy to note this or compensate for printer behavior.
	For HVS, want more spread inthe diagonal (3)
, _,	Seen, like I would be nett, but maybe I
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grow modified by Ken Crounse 2001-02-13
ABSTRACT: module to calculate an optimized order to make the FILE: abs cdo.c halftone dots /********

char abs_cdo_mcd[80]; char abs_cdo_mess[80]; #ifndef abs cdo #include "abs cdo.h" #endif _abs_cdo_

Calculate the square of a double number double abs_cdo_square(/********

return(x*x);

that located in a tile with a horizontal tilesize (xs) and vertical Calculate the normalized distance between two points (x1,y1) and

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* tilesize (ys).

"shortest" distance from (x1,y1) to (x2,y2) in any of the 9 possible

properties • of the tile in both the horizontal and vertical directions and

The distance calculation takes into account the "wrep around"

Calculation of the sequence that is used to make the halftone dots

The algorithm works as follows: Suppose that there are nd dots in a tile, divided into a first group

dots that have already received a ranking number (they can be

by having a "mark" set to one) and a second group of n2 dots that received yet a ranking number.

* The question is than which of the n2 dots will receive the next

ranking • order.

